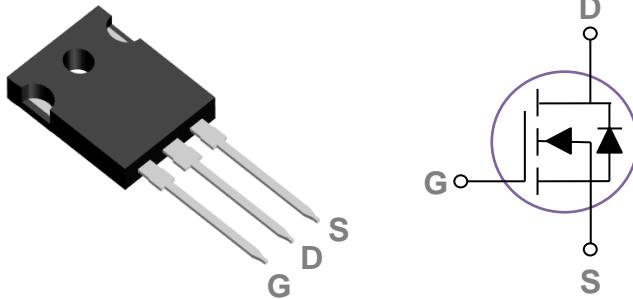


### General Description

These N-Channel enhancement mode power field effect transistors are using super junction MOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

### TO247 Pin Configuration



BVDSS	RDS(ON)	ID
600V	115mΩ	30A

### Features

- 600V,30A, RDS(ON) =115mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

### Applications

- PFC Power Supply Stages
- Motor Control
- DC-DC Converters
- Adapter

### Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	600	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current – Continuous ( $T_c=25^\circ\text{C}$ )	30	A
	Drain Current – Continuous ( $T_c=100^\circ\text{C}$ )	19	A
$I_{DM}$	Drain Current – Pulsed <sup>1</sup>	120	A
EAS	Single Pulse Avalanche Energy	700	mJ
$P_D$	Power Dissipation ( $T_c=25^\circ\text{C}$ )	210	W
	Power Dissipation – Derate above 25°C	1.68	W/°C
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	0.56	°C/W



600V N-Channel MOSFETs

**PJX30N60N****Electrical Characteristics ( $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise noted)****Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=1\text{mA}$	600	---	---	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=25\text{ }^{\circ}\text{C}$	---	---	1	$\mu\text{A}$
		$V_{DS}=480\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=125\text{ }^{\circ}\text{C}$	---	---	10	$\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 30\text{V}$ , $V_{DS}=0\text{V}$	---	---	$\pm 100$	nA

**On Characteristics**

$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}$ , $I_D=15\text{A}$	---	100	115	$\text{m}\Omega$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D = 250\mu\text{A}$	2	3	4	V

**Dynamic and switching Characteristics**

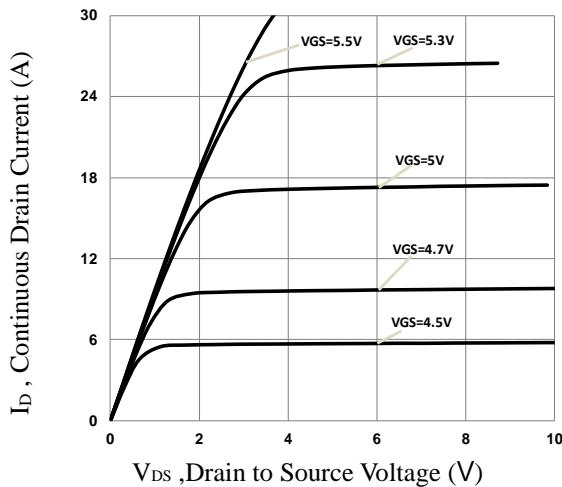
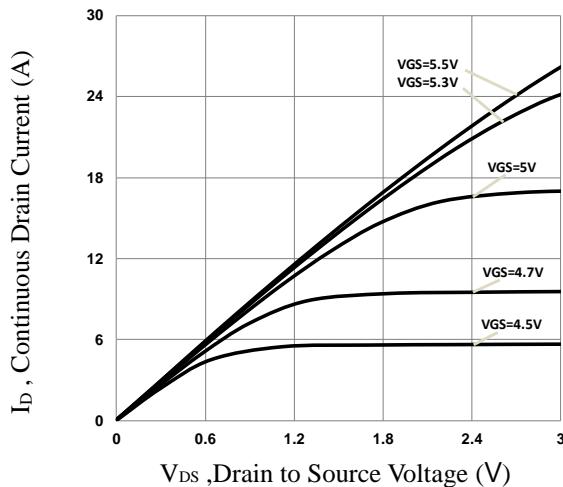
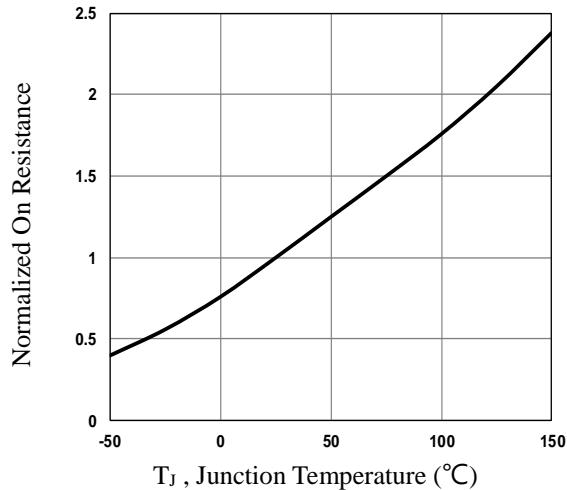
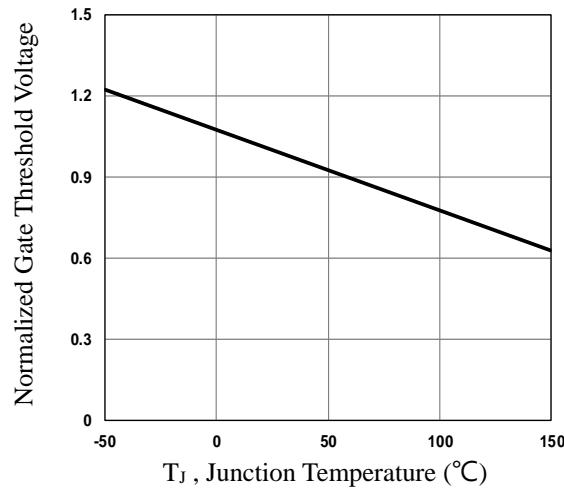
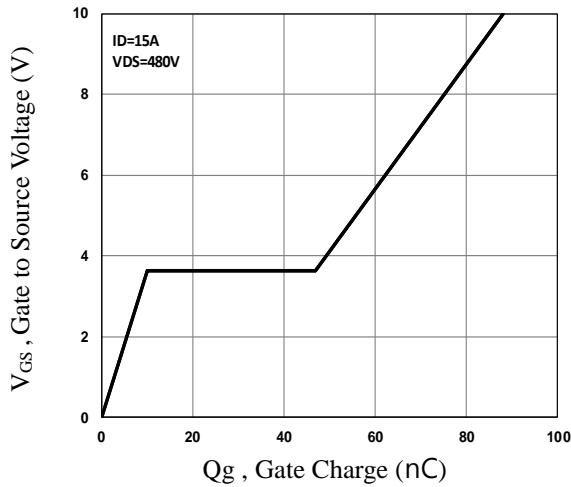
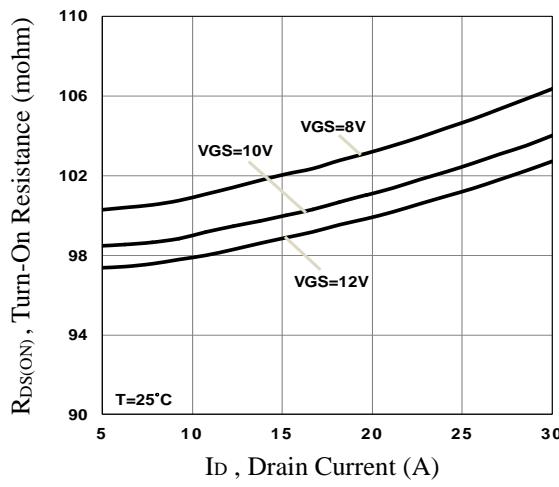
$Q_g$	Total Gate Charge <sup>2,3</sup>	$V_{DS}=480\text{V}$ , $V_{GS}=10\text{V}$ , $I_D=15\text{A}$	---	88	135	nC
$Q_{gs}$	Gate-Source Charge <sup>2,3</sup>		---	10	15	
$Q_{gd}$	Gate-Drain Charge <sup>2,3</sup>		---	37	60	
$T_{d(on)}$	Turn-On Delay Time <sup>2,3</sup>	$V_{DS}=480\text{V}$ , $V_{GS}=10\text{V}$ , $R_G=25\Omega$ $I_D=15\text{A}$	---	50	75	ns
$T_r$	Rise Time <sup>2,3</sup>		---	110	165	
$T_{d(off)}$	Turn-Off Delay Time <sup>2,3</sup>		---	250	375	
$T_f$	Fall Time <sup>2,3</sup>		---	90	135	
$C_{iss}$	Input Capacitance	$V_{DS}=100\text{V}$ , $V_{GS}=0\text{V}$ , $F=1\text{MHz}$	---	2580	3900	pF
$C_{oss}$	Output Capacitance		---	115	175	
$C_{rss}$	Reverse Transfer Capacitance		---	15	25	
$R_g$	Total Gate Charge <sup>2,3</sup>	$V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $F=1\text{MHz}$	---	3	---	$\Omega$

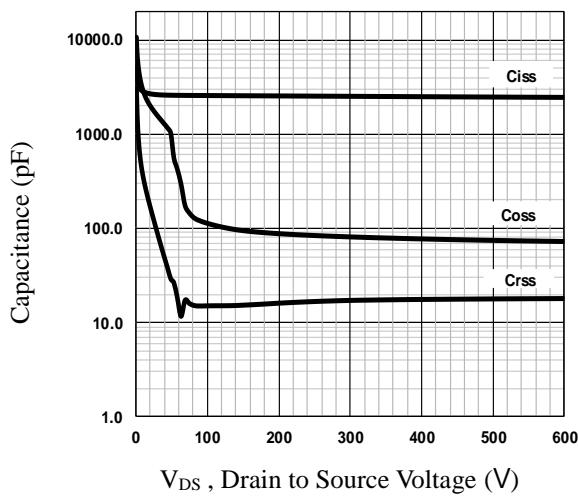
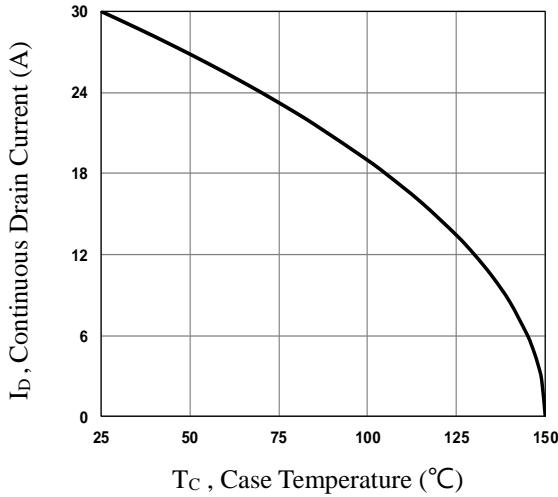
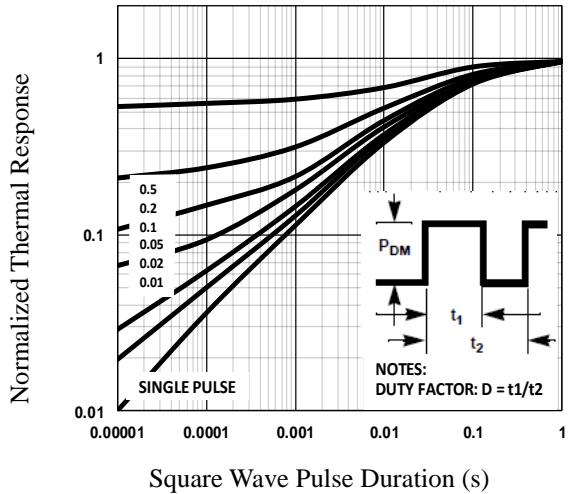
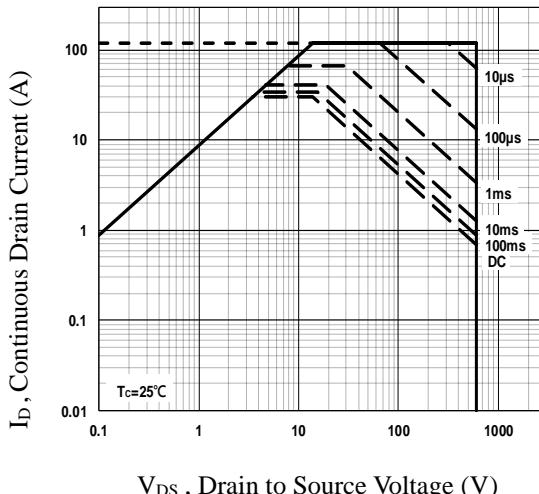
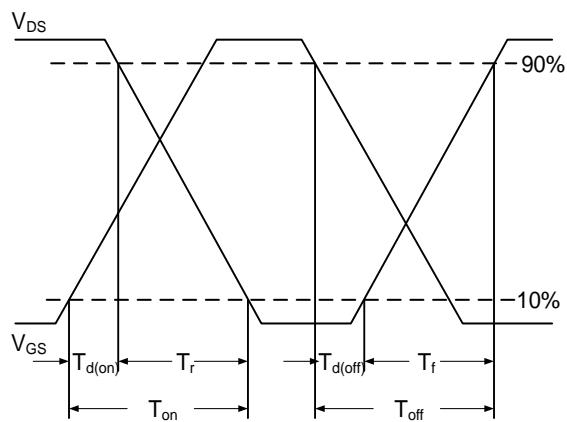
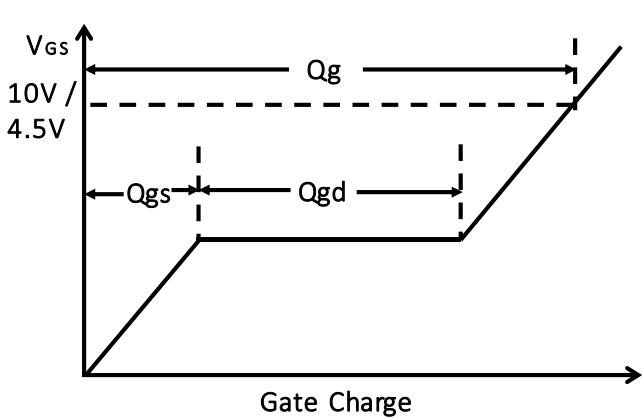
**Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current	$V_G=V_D=0\text{V}$ , Force Current	---	---	30	A
$I_{SM}$	Pulsed Source Current		---	---	60	A
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0\text{V}$ , $I_s=15\text{A}$ , $T_J=25\text{ }^{\circ}\text{C}$	---	---	1.4	V
$t_{rr}$	Reverse Recovery Time	$V_R=400\text{V}$ , $I_s=10\text{A}$	---	370	---	ns
$Q_{rr}$	Reverse Recovery Charge	$di/dt=100\text{A}/\mu\text{s}$ , $T_J=25\text{ }^{\circ}\text{C}$	---	5.2	---	$\mu\text{C}$

Note :

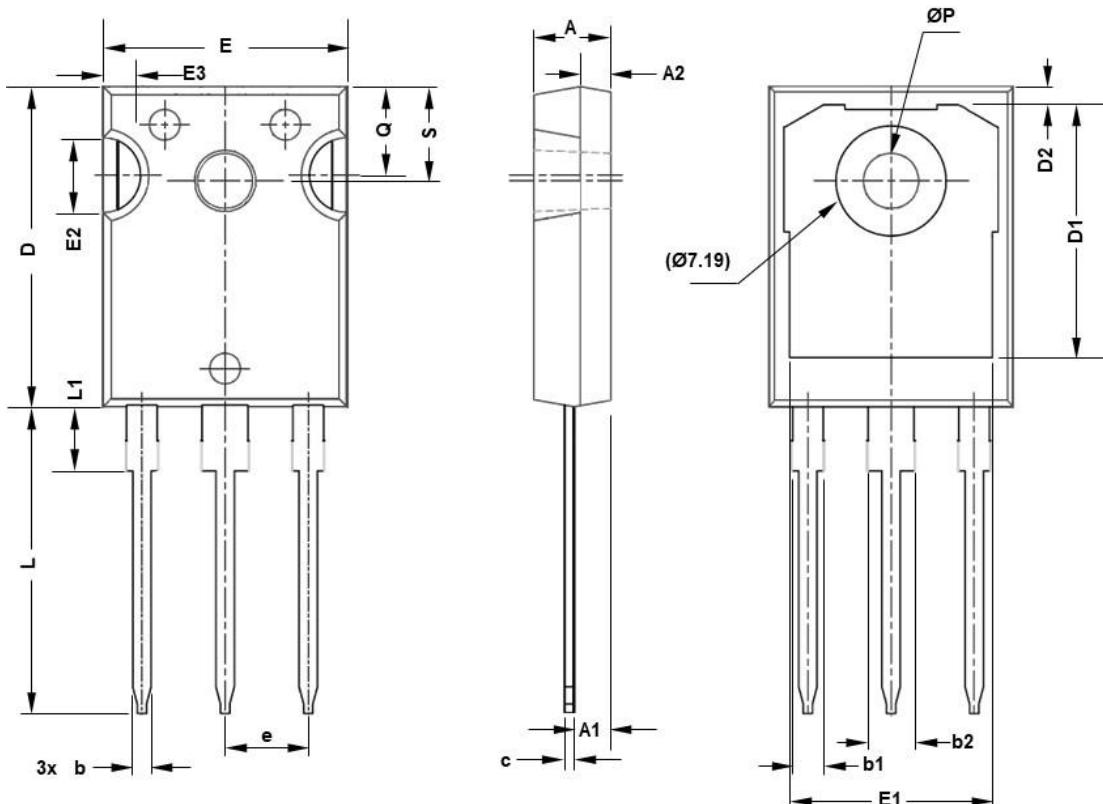
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$ .
3. Essentially independent of operating temperature.


**Fig.1 Typical Output Characteristics**

**Fig.2 Typical Output Characteristics**

**Fig.3 Normalized RDSON vs.  $T_J$** 

**Fig.4 Normalized  $V_{th}$  vs.  $T_J$** 

**Fig.5 Gate Charge Characteristics**

**Fig.6 Turn-On Resistance vs.  $I_D$**


**Fig.7 Capacitance Characteristics**

**Fig.8 Continuous Drain Current vs.  $T_c$** 

**Fig.9 Normalized Transient Impedance**

**Fig.10 Maximum Safe Operation Area**

**Fig.11 Switching Time Waveform**

**Fig.12 Gate Charge Waveform**

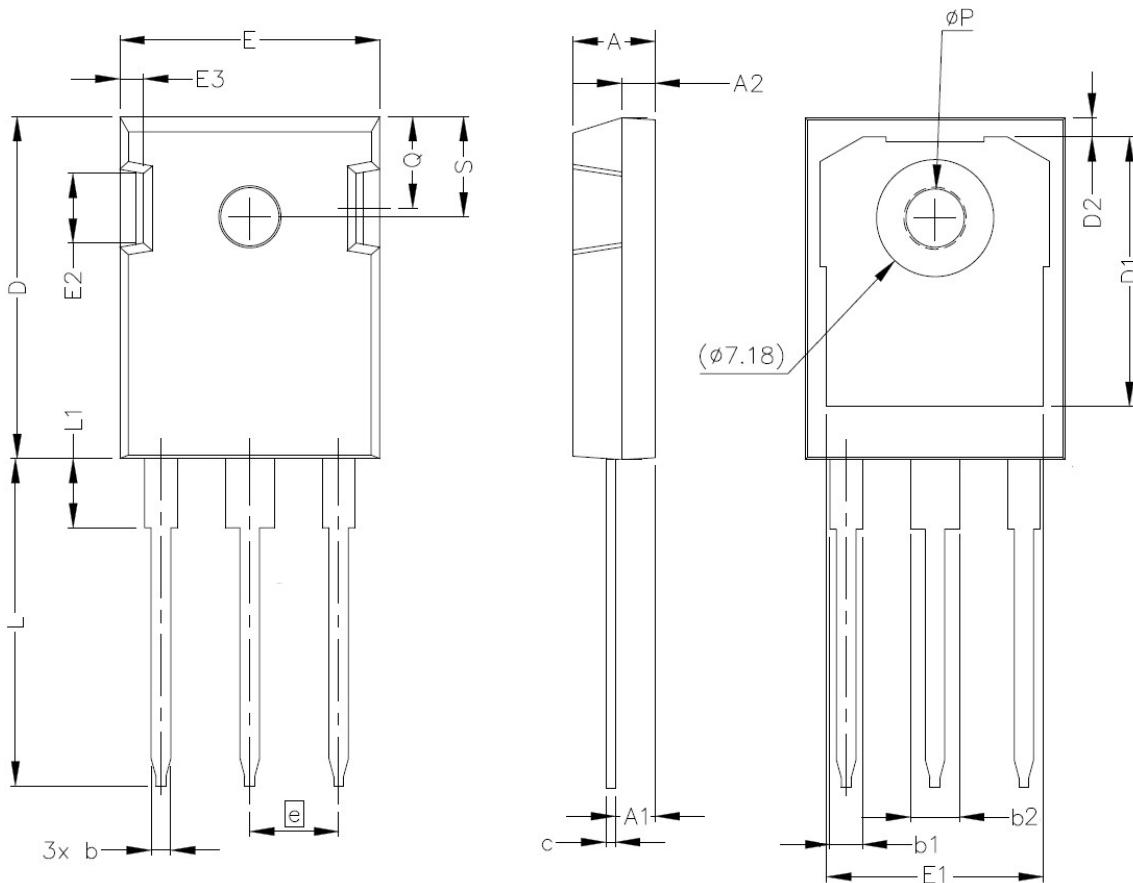
## TO247 PACKAGE INFORMATION

### VERSION A



SYMBOL	mm		SYMBOL	mm	
	MIN	MAX		MIN	MAX
A	4.83	5.21	E2	4.32	5.49
A1	2.29	2.55	E3	2.15	2.80
A2	1.50	2.49	e	5.44BSC	
b	1.12	1.33	L	19.81	20.32
b1	1.91	2.39	L1	4.10	4.40
b2	2.87	3.22	ØP	3.56	3.65
C	0.55	0.69	Q	5.39	6.20
D	20.80	21.10	S	6.04	6.30
D1	16.25	17.65			
D2	0.51	1.35			
E	15.75	16.13			
E1	13.46	14.16			

## VERSION B



SYMBOL	mm		SYMBOL	mm	
	MIN	MAX		MIN	MAX
A	4.75	5.25	E2	3.70	5.30
A1	2.16	2.66	E3	1.00	2.75
A2	1.75	2.25	e	<b>5.44BSC</b>	
b	1.07	1.35	L	19.52	20.32
b1	1.90	2.41	L1	4.10	4.40
b2	2.87	3.38	ΦP	3.35	3.85
C	0.50	0.70	Q	5.40	6.20
D	20.60	21.40	S	<b>6.15BSC</b>	
D1	16.15	17.65			
D2	0.95	1.35			
E	15.50	16.10			
E1	12.40	13.60			